## Notice of References Cited Application/Control No. 10/644,029 Applicant(s)/Patent Under Reexamination NAKAMURA ET AL. Examiner Jack Dinh Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

	Document Number Date						
*		Country Code-Number-Kind Code	MM-YYYY	Name	Classification		
	Α	US-6,385,146	05-2002	Choi et al.	369/44.16		
	В	US-					
	С	US-					
	D	US-					
	E	US-					
	F	US-					
	G	US-					
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	ı	US-					
	J	US-					
	К	US-					
	L	US-					
	М	US-					

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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